Sear	ch Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/601,686	LOCE ET AL.	
Examiner	Art Unit	
Jacky X. Zheng	2625	

	SEARCHED		
Class	Subclass	Date	Examiner
358	2.1	3/5/2007	JZ

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	<u> </u>		

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Inventor Name Search	3/5/3007	JZ
USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB (See EAST Search Notes Attached)	3/6/3007	JZ
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